Power MOSFET

100 V, 24 m Ω , 33 A, Single N-Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6B25NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	100	V
Gate-to-Source Voltage			V _{GS}	±16	V
Continuous Drain Cur-	Steady	T _C = 25°C	I _D	33	Α
rent $R_{\theta JC}$ (Notes 1, 2, 3)		T _C = 100°C		23	
Power Dissipation	State	T _C = 25°C	P _D	62	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		31	
Continuous Drain Cur-	Steady	T _A = 25°C	I _D	8	Α
rent $R_{\theta JA}$ (Notes 1, 2, 3)		T _A = 100°C		6	
Power Dissipation	State	T _A = 25°C	P _D	3.6	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^\circ$	°C, t _p = 10 μs	I _{DM}	177	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to + 175	°C
Source Current (Body Diode)			I _S	48	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 2.0 A)			E _{AS}	170	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2.4	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	42	

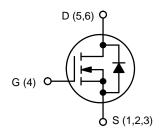
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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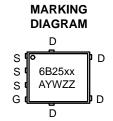
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
100 V	24 mΩ @ 10 V	33 A
	39 mΩ @ 4.5 V	33 A



N-CHANNEL MOSFET



STYLE 1



6B25NL = NVMFS6B25NL 6B25LW = NVMFS6B25NLWF A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				64		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	T _J = 25°C			10	μΑ
		V _{DS} = 80 V	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 16 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		1.0		3.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	·			-5.4		mV/°C
	V _{GS} = 10	V _{GS} = 10 V			19.8	24	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 20 A		31	39	
CHARGES, CAPACITANCES & GATE RE	SISTANCE		•	•	•		•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			905		pF
Output Capacitance	C _{OSS}				302		
Reverse Transfer Capacitance	C _{RSS}				23		
	_	V _{GS} = 4.5 V, V _{DS} = 50 V; I _D = 25 A			6.4		nC
Total Gate Charge	$Q_{G(TOT)}$	V _{GS} = 10 V, V _{DS} = 50 V; I _D = 25 A			13.5		
Threshold Gate Charge	Q _{G(TH)}				1.8		
Gate-to-Source Charge	Q _{GS}				3.6		
Gate-to-Drain Charge	Q_GD				1.8		
Plateau Voltage	V _{GP}				3.7		V
SWITCHING CHARACTERISTICS (Note	5)					ı	
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 50 \text{ V},$ $I_{D} = 25 \text{ A}, R_{G} = 1.0 \Omega$			9.6		ns
Rise Time	t _r				79		
Turn-Off Delay Time	t _{d(OFF)}				18.3		
Fall Time	t _f				73		
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 25 A	T _J = 25°C		0.91	1.2	
-			T _J = 125°C		0.81		-
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 20 \text{ A}$			40.4		ns
Charge Time	t _a				24.5		
Discharge Time	t _b				15.9		
Reverse Recovery Charge	Q _{RR}				50		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

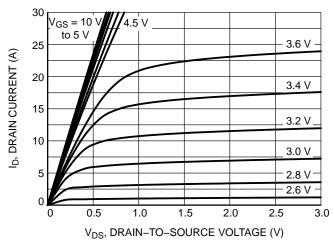


Figure 1. On-Region Characteristics

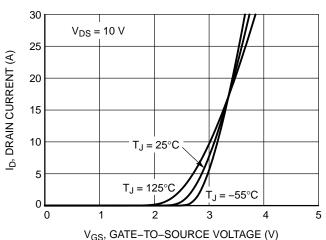


Figure 2. Transfer Characteristics

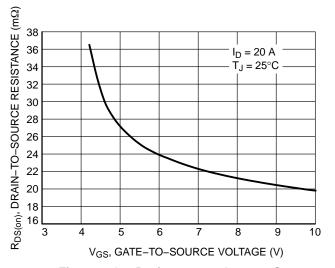


Figure 3. On–Resistance vs. Gate–to–Source Voltage

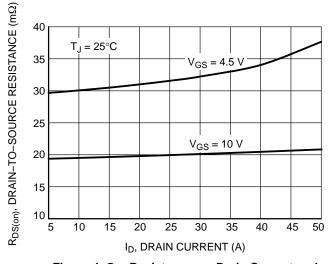


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

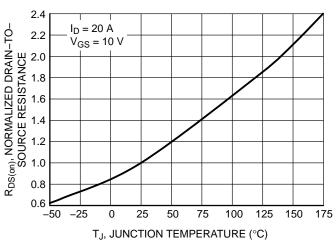


Figure 5. On–Resistance Variation with Temperature

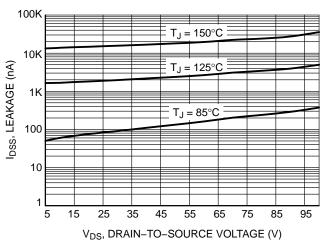
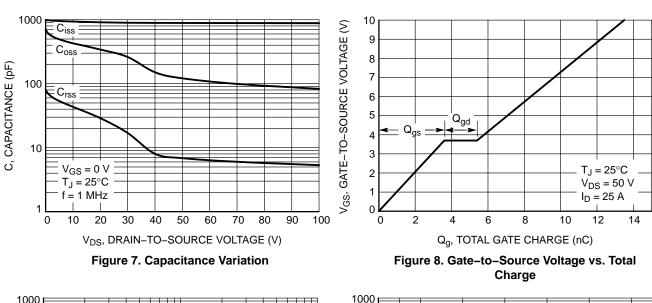


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



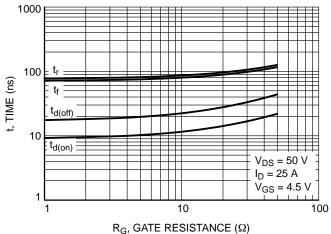


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

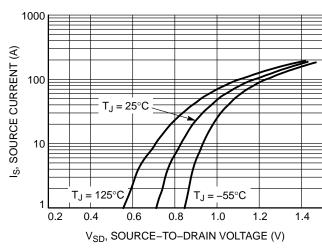


Figure 10. Diode Forward Voltage vs. Current

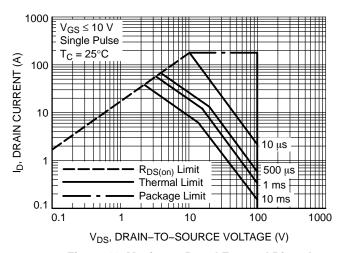


Figure 11. Maximum Rated Forward Biased Safe Operating Area

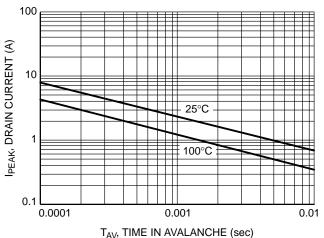


Figure 12. I_{PEAK} vs. T_{AV}

TYPICAL CHARACTERISTICS

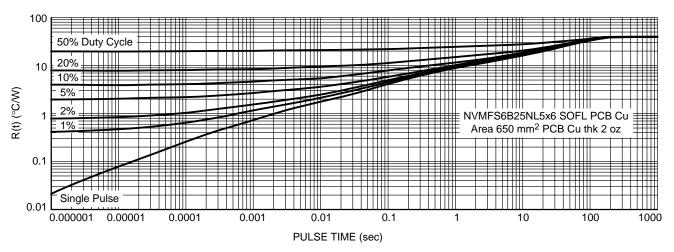


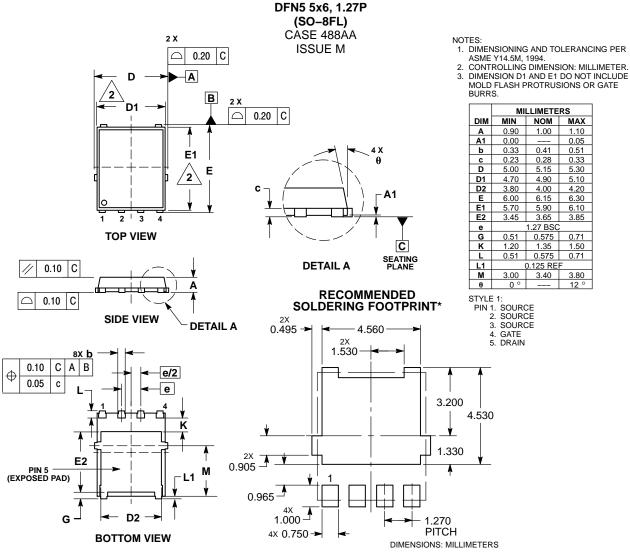
Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS6B25NLT1G	6B25NL	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS6B25NLWFT1G	6B25LW	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS6B25NLT3G	6B25NL	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS6B25NLWFT3G	6B25LW	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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